

### **IGBT R8 Modules**

#### SKM1000GB17R8

#### Features\*

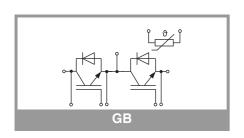
- · Symmetrical current sharing
- Low-inductive module design
- High mechanical robustness
- UL recognized, file no. E63532

#### **Typical Applications**

- Motor Drives
- UPS Systems
- Solar Inverters

#### **Remarks**

Recommended  $T_{jop} = -40 \dots +150$ °C



Absolute Maximum Ratings							
Symbol	Conditions		Values	Unit			
IGBT				'			
$V_{CES}$	T <sub>j</sub> = 25 °C		1700	V			
Ic	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	1574	Α			
		T <sub>c</sub> = 100 °C	1027	Α			
I <sub>Cnom</sub>			1000	Α			
I <sub>CRM</sub>	I <sub>CRM</sub> = 2 x I <sub>Cnom</sub>		2000	Α			
$V_{GES}$			-20 20	V			
t <sub>psc</sub>	$V_{CC} = 1200 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 1700 \text{ V}$	T <sub>j</sub> = 150 °C	10	μѕ			
Tj			-40 175	°C			
Inverse d	iode						
$V_{RRM}$	T <sub>j</sub> = 25 °C		1700	V			
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	1449	Α			
		T <sub>c</sub> = 100 °C	905	Α			
$I_{Fnom}$			1000	Α			
I <sub>FRM</sub>	I <sub>FRM</sub> = 2 x I <sub>Fnom</sub>		2000	Α			
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C		6240	Α			
Tj			-40 175	°C			
Module							
T <sub>stg</sub>			-40 150	°C			
V <sub>isol</sub>	AC sinus 50 Hz, t = 1 min		4000	V			

Characteristics									
Symbol	Conditions	min.	typ.	max.	Unit				
IGBT									
V <sub>CE(sat)</sub>	$I_C = 1000 \text{ A}$ $V_{GE} = 15 \text{ V}$ chiplevel	T <sub>j</sub> = 25 °C		1.66	1.99	V			
		T <sub>j</sub> = 150 °C		2.01	2.33	V			
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.06	1.12	V			
		T <sub>j</sub> = 150 °C		0.95	1.05	V			
	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25 °C		0.60	0.87	mΩ			
	chiplevel	T <sub>j</sub> = 150 °C		1.06	1.28	mΩ			
$V_{GE(th)}$	$V_{GE}=V_{CE}$ , $I_{C}=36$ m	ıA	5	5.8	6.5	V			
I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1700 V, T <sub>j</sub> = 25 °C				6.0	mA			
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		90.0		nF			
C <sub>oes</sub>		f = 1 MHz		3.00		nF			
C <sub>res</sub>		f = 1 MHz		0.24		nF			
$Q_{G}$	V <sub>GE</sub> = -15V / +15V			5640		nC			
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			1.8		Ω			
t <sub>d(on)</sub>	$V_{CC} = 900 \text{ V}$ $I_C = 1000 \text{ A}$ $V_{GE} = +15/-15 \text{ V}$ $R_{G \text{ on}} = 0.7 \Omega$ $R_{G \text{ off}} = 0.7 \Omega$	T <sub>j</sub> = 150 °C		476		ns			
t <sub>r</sub>		T <sub>j</sub> = 150 °C		105		ns			
Eon		T <sub>j</sub> = 150 °C		465		mJ			
t <sub>d(off)</sub>		T <sub>j</sub> = 150 °C		713		ns			
t <sub>f</sub>		T <sub>j</sub> = 150 °C		158		ns			
E <sub>off</sub>	$\begin{array}{l} \text{di/dt}_{\text{off}} = 4.8 \text{ kA/}\mu\text{s} \\ \text{dv/dt} = 4600 \text{ V/}\mu\text{s} \\ \text{L}_{\text{s}} = 24 \text{ nH} \end{array}$	T <sub>j</sub> = 150 °C		332		mJ			
R <sub>th(j-c)</sub>	per IGBT				0.03	K/W			
R <sub>th(c-s)</sub>	per IGBT (λ <sub>grease</sub> =0.81 W/(m*K))			0.016		K/W			



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**Typical Applications** 

• Motor Drives

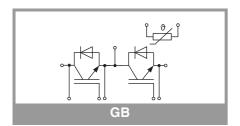
• UPS Systems

Solar Inverters

**Remarks** 

Recommended  $T_{jop} = -40 \dots +150^{\circ}C$ 

Characteristics								
Symbol	Conditions		min.	typ.	max.	Unit		
Inverse diode								
$V_F = V_{EC}$	I <sub>F</sub> = 1000 A	T <sub>j</sub> = 25 °C		1.78	2.12	V		
	V <sub>GE</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		1.81	2.14	V		
$V_{F0}$	chiplevel	T <sub>j</sub> = 25 °C		1.32	1.56	V		
	Chipievei	T <sub>j</sub> = 150 °C		1.08	1.22	V		
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.46	0.56	mΩ		
	<u> </u>	T <sub>j</sub> = 150 °C		0.73	0.92	mΩ		
I <sub>RRM</sub>	I <sub>F</sub> = 1000 A	T <sub>j</sub> = 150 °C		711		Α		
Q <sub>rr</sub>	di/dt <sub>off</sub> = 8.1 kA/μs V <sub>GE</sub> = -15 V	T <sub>j</sub> = 150 °C		325		μС		
E <sub>rr</sub>	V <sub>CC</sub> = 900 V	T <sub>j</sub> = 150 °C		159		mJ		
R <sub>th(j-c)</sub>	per diode			0.042	K/W			
R <sub>th(c-s)</sub>	per diode (λ <sub>grease</sub> =0.81 W/(m*K))			0.017		K/W		
Module								
L <sub>CE</sub>				10		nH		
R <sub>CC'+EE'</sub>	measured per swite	ch, T <sub>C</sub> = 25 °C		0.2		mΩ		
R <sub>th(c-s)1</sub>	calculated without thermal coupling (\(\lambda_{\text{qrease}} = 0.81 \text{ W/(m*K))}\)		0.0041			K/W		
R <sub>th(c-s)2</sub>	including thermal coupling, T <sub>s</sub> underneath module (λ <sub>grease</sub> =0.81 W/(m*K))			0.007		K/W		
Ms	to heat sink M5		4		6	Nm		
Mt		to terminals M8	8		10	Nm		
		to terminals M4	1.8		2.1	Nm		
w					1250	g		
Temperat	ture Sensor							
R <sub>100</sub>	T <sub>c</sub> =100°C (R <sub>25</sub> =5 kΩ)			493 ± 5%		Ω		
B <sub>100/125</sub>	$R_{(T)}=R_{100}exp[B_{100/125}(1/T-1/T_{100})]; T[K];$			3550 ±2%		К		



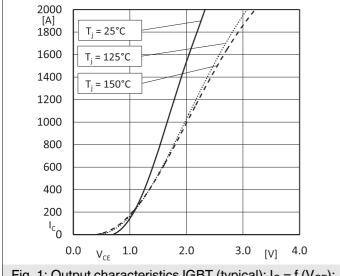


Fig. 1: Output characteristics IGBT (typical);  $I_C = f(V_{CE})$ ;  $V_{GE} = 15V$ ; (chiplevel)

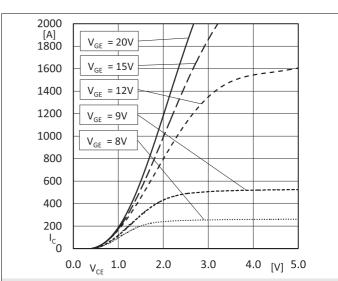


Fig. 2: Output characteristics IGBT (typical);  $I_C = f(V_{CE})$ ;  $T_i = 150 \,^{\circ}\text{C}$ ; (chiplevel)

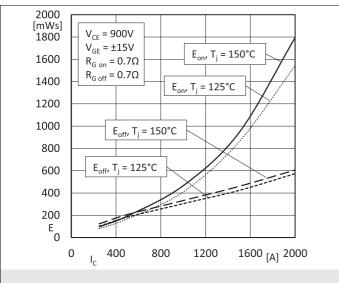


Fig. 3: Switching losses IGBT (typical); E=f(I<sub>C</sub>)

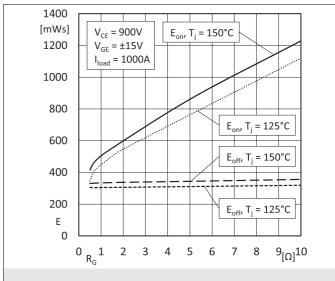
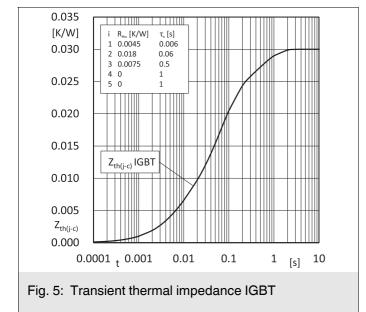
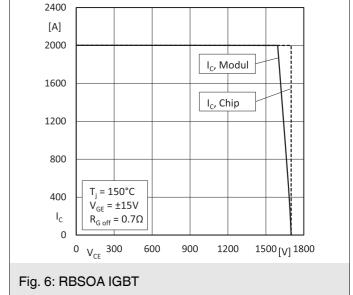


Fig. 4: Switching losses IGBT (typical); E=f(R<sub>G</sub>)





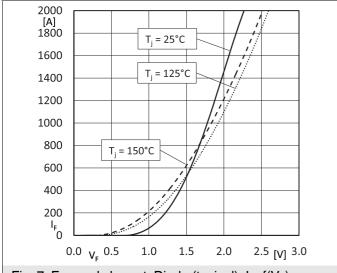


Fig. 7: Forward charact. Diode (typical);  $I_F=f(V_F)$ ; (chiplevel)

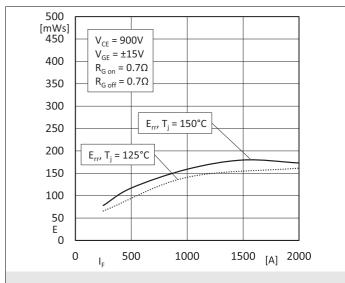


Fig. 8: Switching losses Diode (typical); E=f(I<sub>F</sub>)

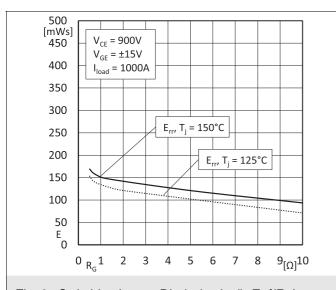


Fig. 9: Switching losses Diode (typical); E=f(R<sub>G</sub>)

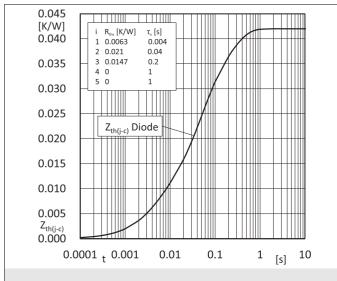
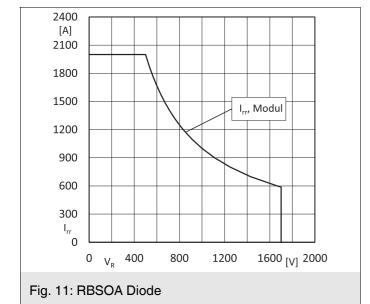
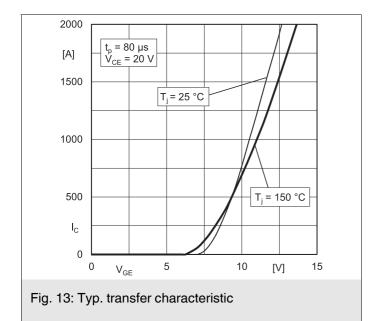


Fig. 10: Transient thermal impedance Diode





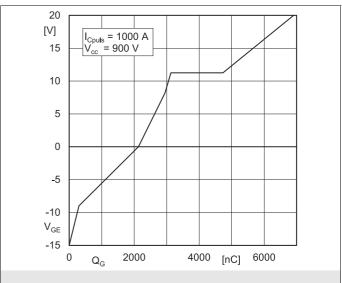
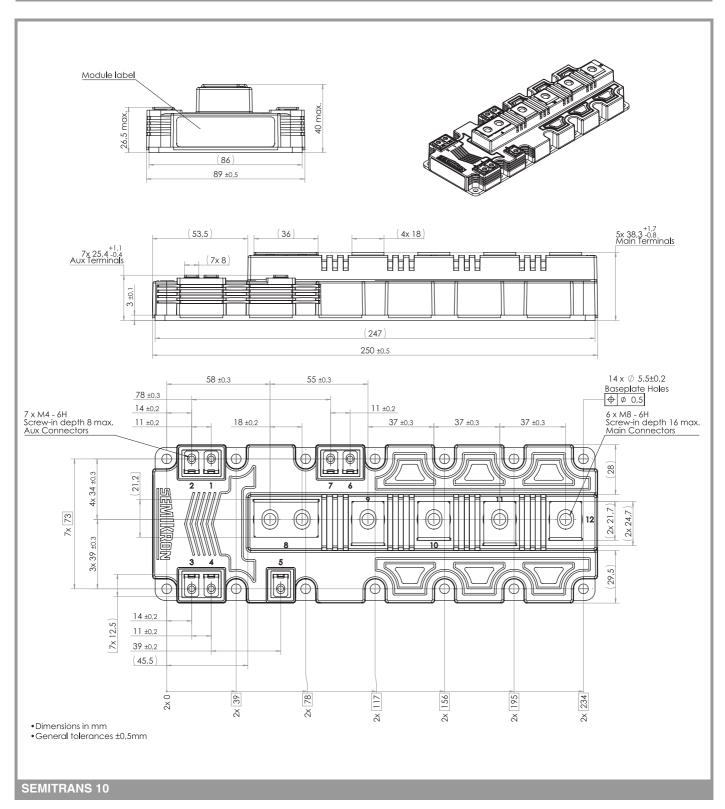
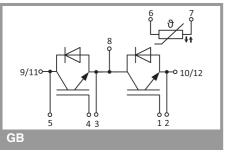


Fig. 14: Typ. gate charge characteristic





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

#### \*IMPORTANT INFORMATION AND WARNINGS

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